

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MCGOWAN ET AL.	
		Examiner Brian P. Whipple	Art Unit 2152	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0046375 A1	03-2003	Parkman et al.	709/220
*	B	US-2003/0065670 A1	04-2003	Bisson et al.	707/100
*	C	US-2004/0260565 A1	12-2004	Zimniewicz et al.	705/001
*	D	US-5,784,563 A	07-1998	Marshall et al.	709/221
*	E	US-5,875,327 A	02-1999	Brandt et al.	713/1
*	F	US-5,950,010 A	09-1999	Hesse et al.	717/178
*	G	US-6,029,196 A	02-2000	Lenz, Michael A.	709/221
*	H	US-6,052,720 A	04-2000	Traversat et al.	709/220
*	I	US-6,105,063 A	08-2000	Hayes, Jr., Kent Fillmore	709/223
*	J	US-6,205,476 B1	03-2001	Hayes, Jr., Kent Fillmore	709/220
*	K	US-6,988,132 B2	01-2006	Horvitz, Eric	709/220
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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